

<b>Notice of References Cited</b>	Application/Control No. 09/819,826	Applicant(s)/Patent Under Reexamination WASIK ET AL.	
	Examiner Anthony T Ton	Art Unit 2661	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-2002/0022483 a1	02-2002	Thompson et al.	455/439
	B	US-2002/0007407 a1	01-2002	Klein, John Raymond	709/225
	C	US-6,778,519	08-2004	Harrell et al.	370/342
	D	US-5,889,965	03-1999	Wallach et al.	710/302
	E	US-2002/0101848 a1	08-2002	Lee et al.	370/349
	F	US-6,536,670	03-2003	Postman et al.	235/487
	G	US-6,480,486	11-2002	Kikinis, Dan	370/354
	H	US-2001/0024953 a1	09-2001	Balogh, Peter	455/432
	I	US-2002/0141382	10-2002	Winther et al.	370/352
	J	US-5,774,461	06-1998	Hyden et al.	370/310.2
	K	US-2003/0193895	10-2003	Engwer et al.	370/241
	L	US-6,408,333	06-2002	St. Clair, William G.	709/222
	M	US-6,130,896	10-2000	Lueker et al.	370/469

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.